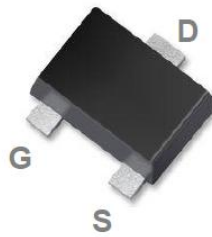
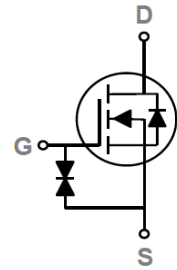


Main Product Characteristics:

V_{DSS}	20V
$R_{DS(on)}$	200m Ω (typ.)
I_D	800mA


SOT-723

Schematic diagram
Features and Benefits:

- Advanced trench MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- High Power and current handling capability
- Fully Avalanche Rated


Description:

It utilizes the advanced trench processing techniques to achieve extremely low on resistance and low gate charge. These features combine to make this design an extremely efficient and reliable device for use in PWM, load switching and a wide variety of other applications.

Absolute max Rating:

Symbol	Parameter	Max.	Units
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ ①	800	mA
$I_D @ T_C = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ ①	510	
I_{DM}	Pulsed Drain Current②	3200	
$P_D @ T_C = 25^\circ\text{C}$	Power Dissipation③	450	W
V_{DS}	Drain-Source Voltage	20	V
V_{GS}	Gate-to-Source Voltage	± 8	V
T_J	Operating Junction and	-55 to + 150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to + 150	$^\circ\text{C}$

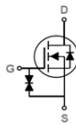
Thermal Resistance

Symbol	Characterizes	Value	Unit
$R_{\theta JA}$	Junction-to-ambient ($t \leq 10s$) ④	280	$^{\circ}C/W$

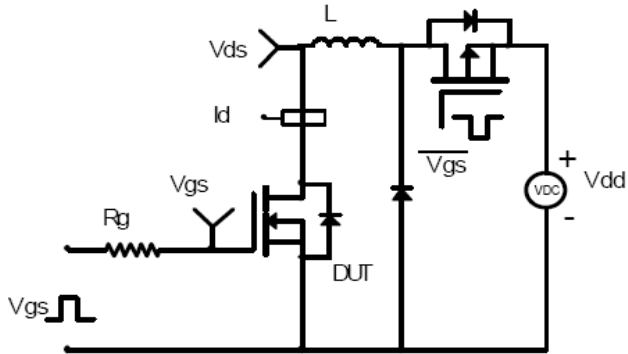
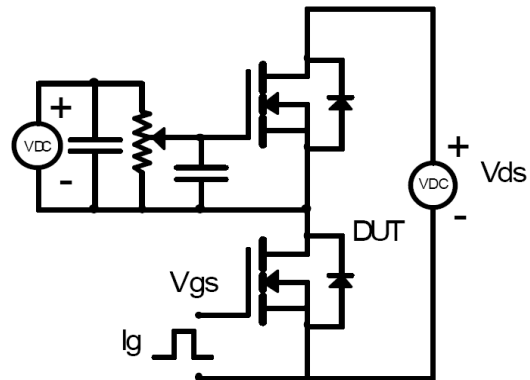
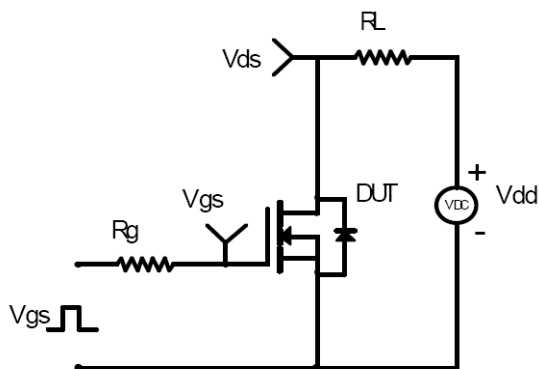
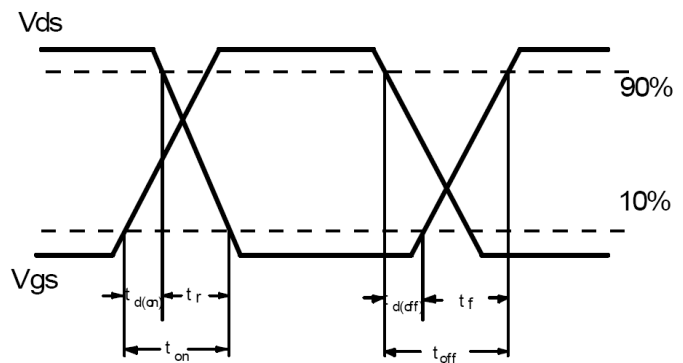
Electrical Characterizes @ $T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source breakdown voltage	20	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$R_{DS(on)}$	Static Drain-to-Source on-resistance	—	200	300	m Ω	$V_{GS}=4.5V, I_D = 0.5A$
			300	450		$V_{GS}=2.5V, I_D = 0.4A$
			500	700		$V_{GS}=1.8V, I_D = 0.2A$
			800	1200		$V_{GS}=1.5V, I_D = 0.1A$
			1200	2500		$V_{GS}=1.2V, I_D = 0.1A$
$V_{GS(th)}$	Gate threshold voltage	0.3	0.5	0.85	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
I_{DSS}	Drain-to-Source leakage current	—	—	1	μA	$V_{DS} = 20V, V_{GS} = 0V$
I_{GSS}	Gate-to-Source forward leakage	—	—	20	μA	$V_{GS} = 8V$
	Gate-to-Source reverse leakage	—	—	-20		$V_{GS} = -8V$
Q_g	Total gate charge	—	1	2	nC	$I_D = 0.5A,$ $V_{DS}=10V,$ $V_{GS} = 4.5V$
Q_{gs}	Gate-to-Source charge	—	0.26	0.5		
Q_{gd}	Gate-to-Drain("Miller") charge	—	0.2	0.4		
$t_{d(on)}$	Turn-on delay time	—	5	10	ns	$V_{GS}=4.5V, V_{DS}=10V,$ $R_{GEN}=10\Omega, I_D = 0.5A$
t_r	Rise time	—	3.5	7		
$t_{d(off)}$	Turn-Off delay time	—	14	28		
t_f	Fall time	—	6	12		
C_{iss}	Input capacitance	—	38	75	pF	$V_{DS}=10V,$ $V_{GS}=0V,$ $f=1MHz$
C_{oss}	Output capacitance	—	14	29		
C_{rss}	Reverse transfer capacitance	—	6	12		

Source-Drain Ratings and Characteristics

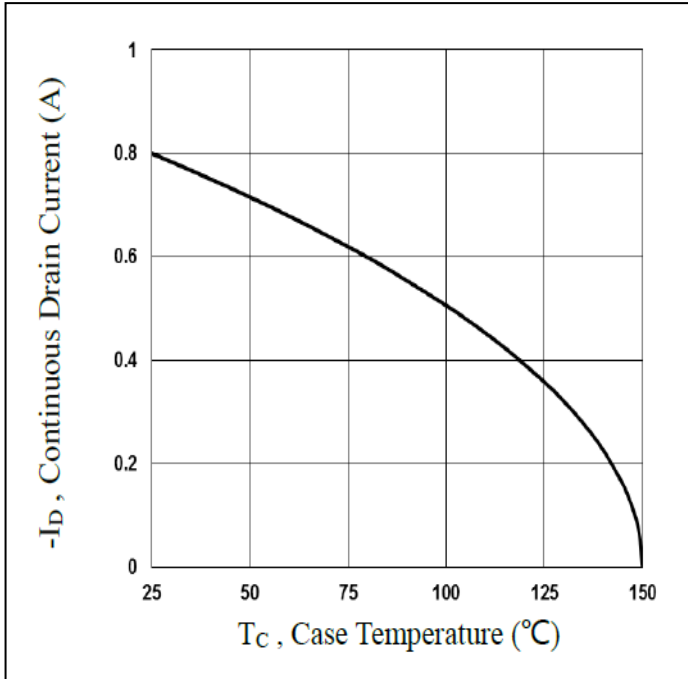
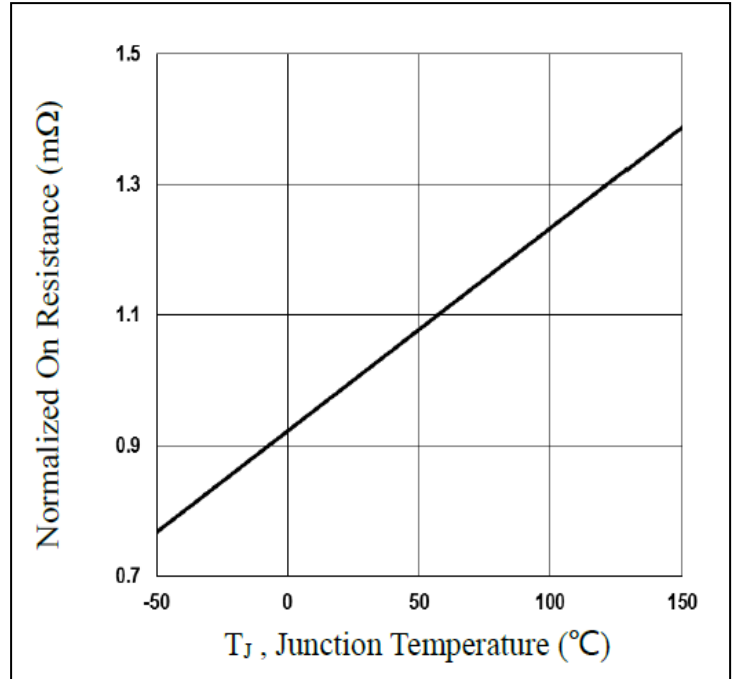
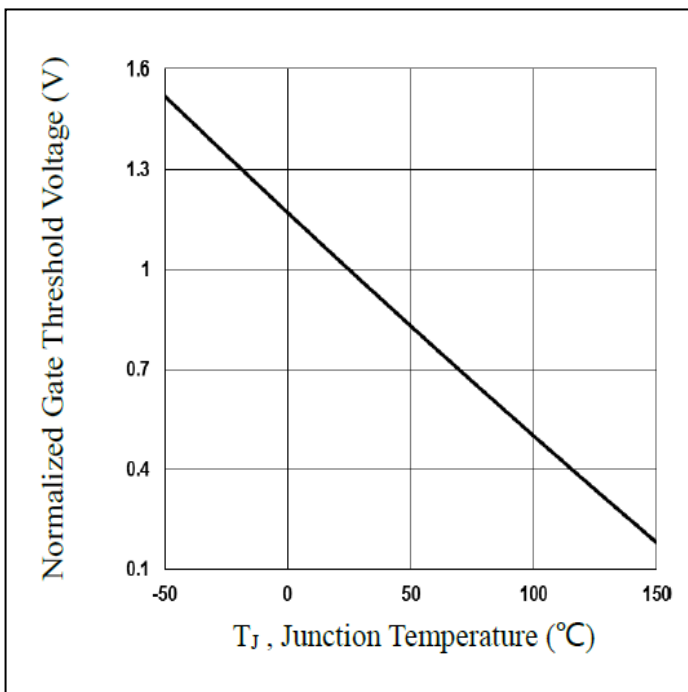
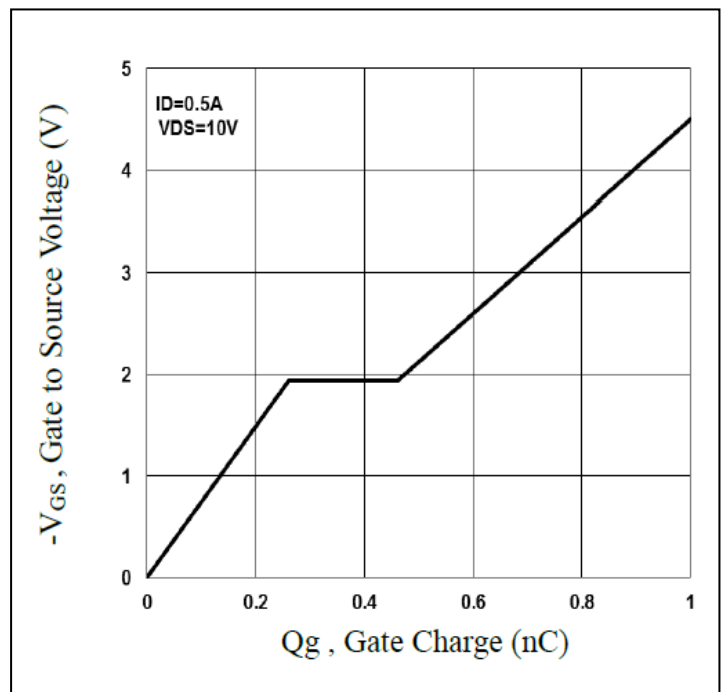
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Maximum Body-Diode Continuous Current	—	0.8	—	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Maximum Body-Diode Pulse Current	—	1.6	—	A	
V_{SD}	Diode Forward Voltage	—	—	1	V	$T_J=25^{\circ}C, I_S=0.2A, V_{GS}=0V$

Test circuits and Wave forms

EAS Test Circuit:

Gate charge test circuit:

Switching Time Test Circuit:

Switching Waveforms:


Notes:

- ① Calculated continuous current based on maximum allowable junction temperature.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ The power dissipation P_D is based on max. junction temperature, using junction-to-case thermal resistance.
- ④ The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ\text{C}$

Typical electrical and thermal characteristics

Figure 1: Continuous Drain Current

Figure 2: Normalized Rdson Vs. T_j

Figure 3: Normalized V_{th} Vs. T_j

Figure 4: Gate Charge Waveform

Typical electrical and thermal characteristics

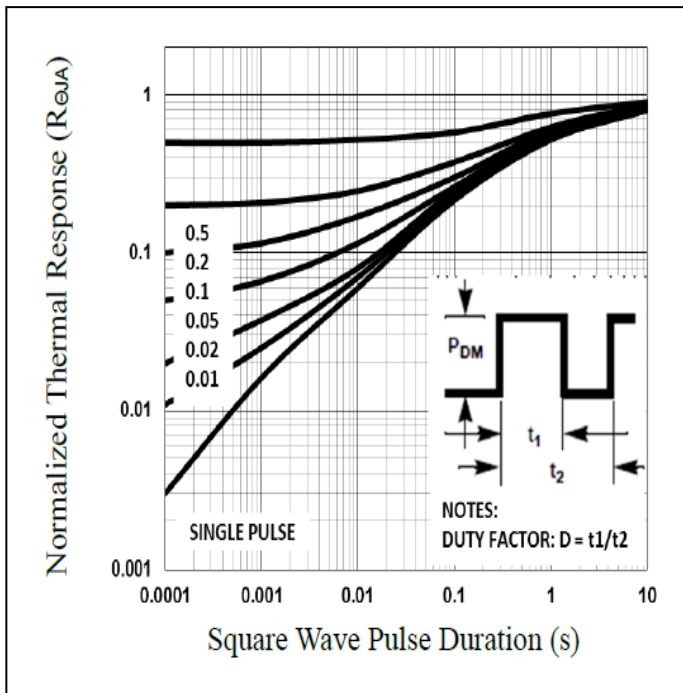


Figure 5. Normalized Transient Response

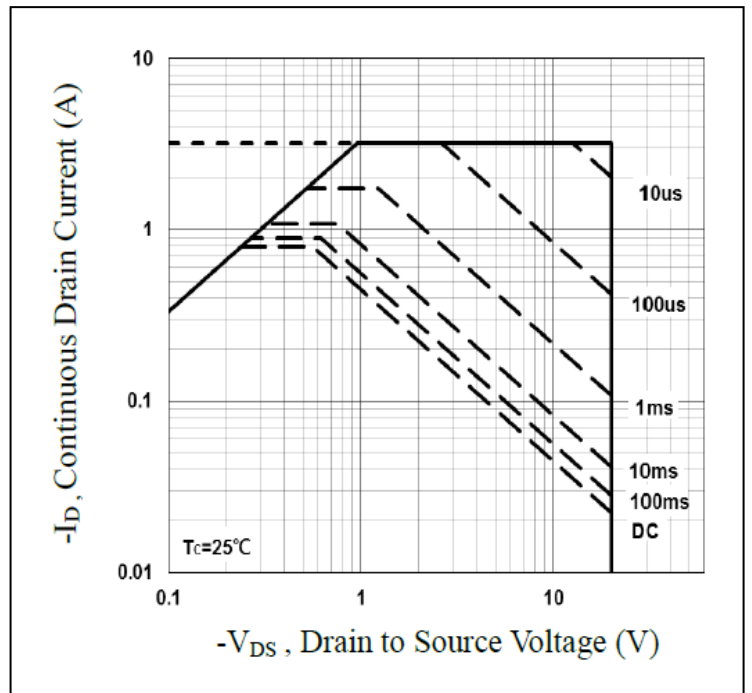
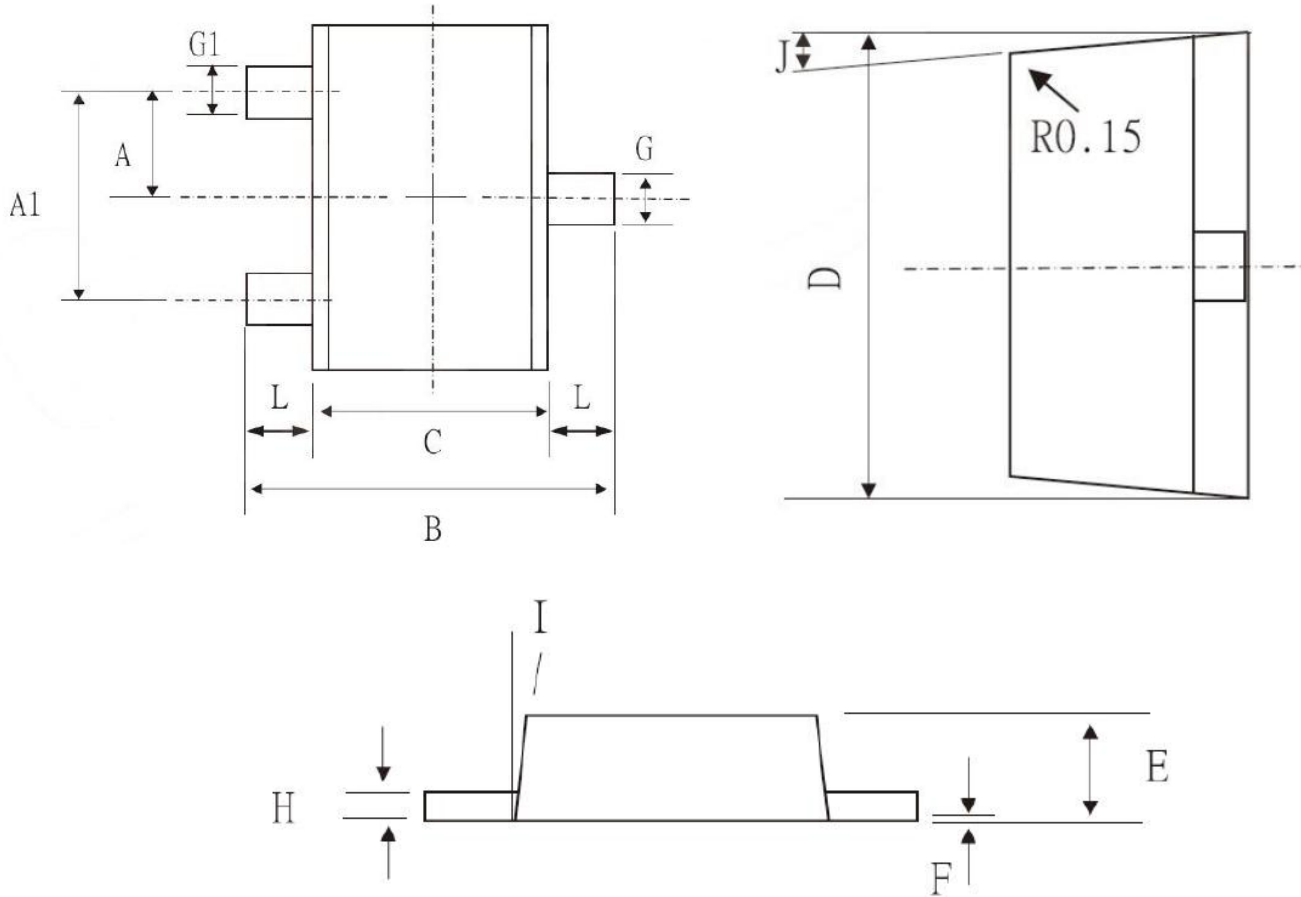


Figure 6. Maximum Safe Operation Area

Mechanical Data:
SOT-723:


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	MAX	MIN	MAX	MIN
A	0.4BSC		0.016BSC	
A1	0.8BSC		0.031BSC	
B	1.250	1.150	0.049	0.045
C	0.850	0.750	0.033	0.030
D	1.250	1.150	0.049	0.045
E	0.390	0.370	0.015	0.015
F	0.050	0.000	0.002	0.000
G	0.270	0.220	0.011	0.009
G1	0.220	0.170	0.009	0.007
H	0.110	0.009	0.004	0.000
I	13°	9°	13°	9°
L	0.250	0.150	0.010	0.006
J	11°	7°	11°	7°

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Sales@silikron.com

Technical Support:

Technical@silikron.com

Suzhou Silikron Semiconductor Corp.

501 , NW-20,Nanopolis, 99th Jinjihu Avenue ,Industrial Park ,Suzhou ,P.R, CHINA

TEL: (86-512) 62560688

FAX: (86-512) 62560688-8092

E-mail: Sales@silikron.com